

Search Notes

Application/Control No.

10/784,298

Examiner

KIEU-OANH T. BUI

Applicant(s)/Patent under
Reexamination

NISHIOKA ET AL.

Art Unit

2623

SEARCHED

Class	Subclass	Date	Examiner
725	51,55,110, 112	4/21/2006	KB
709	79,203		
	216,217,		
	250		
370	535		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search 725 and text 370, 709	4/21/2006	KB